

Department of Electronics & Communication Engineering

Faculty of Engineering, Integral University, Lucknow

Quiz 1

Semiconductor Device Modeling & Circuit Simulation (GEC-101)

Candidate Name :

Date : 22-January-2013

Maximum Marks : 10

Group: First Year M.Tech Part Time

Note : Last two questions are two marks each.

1. Maximum value of electric field in PN junction occurred at
 - (a). Junction Point
 - (b). Middle of the depletion layer
 - (c). End of the depletion layer
 - (d). None of these
2. Relationship between doping level and depletion width is given as
 - (a). Inversely
 - (b). Linear
 - (c). Square
 - (d). None of these
3. Minority carrier diffusion length in forward bias PN junction is given mathematically as
 - (a). $L_p = \sqrt{(D_p \tau_p)}$
 - (b). $L_p = (D_p \tau_p)$
 - (c). $L_p = (D_p / \tau_p)$
 - (d). $L_p = (D_p \tau_p)^{-1}$
4. The change in stored charges with forward bias voltage exhibits capacitive effect resulting in
 - (a). Depletion Capacitance
 - (b). Diffusion Capacitance
 - (c). Inductance
 - (d). None of these
5. Give the mathematical expression for the Mass Action Law

